

1. General description

TSPM1 module with WeEn 1200V Gen2 SiC MOSFET. Intergrated with NTC temperature sensor.



2. Features and benefits

- Half bridge topology
- Built-in NTC temperature sensor
- Low on-resistance
- Fast switching speed
- 0V turn-off V_{GS} for simple gate driving
- 100% UIS Tested
- Low Switching Losses
- Low Inductive Design
- RoHS compliant

3. Applications

- Automotive DC-DC converters
- Automotive on-board chargers
- Automotive compressor drivers

4. Quick reference data

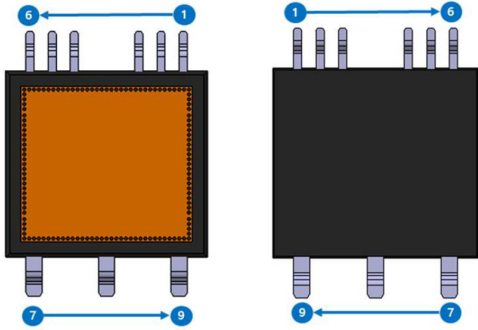
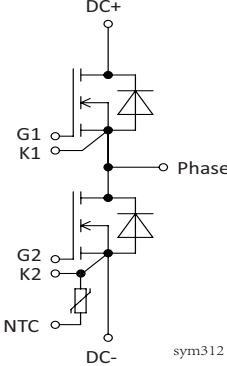
Table 1. Quick reference data

Table 1: Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
Absolute maximum rating							
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		1200			V
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C		50			A
P _{tot}	total power dissipation	T _{mb} = 25 °C		169			W
T _j	junction temperature			-55 to 175			°C
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
R _{DS(on)}	drain-source on-state resistance	V _{GS} = 15 V; I _D = 33 A; T _j = 25 °C		-	40	-	mΩ
		V _{GS} = 18 V; I _D = 33 A; T _j = 25 °C		-	33	-	mΩ
Dynamic characteristics							
Q _{G(tot)}	total gate charge	I _D = 33 A; V _{DS} = 800 V; V _{GS} = -4 V/18 V; T _j = 25 °C		-	115	-	nC
Q _{GD}	gate-drain charge			-	18	-	nC
Source-drain diode							
Q _r	recovered charge	I _{SD} = 33 A; di/dt = 500 A/μs; V _{DS} = 400 V; T _j = 25 °C		-	174	-	nC

5. Pinning information

Table 2. Pinning information

Pin	Description	Simplified outline	Circuit diagram
1	G1		
2	K1		
3	N/C		
4	NTC		
5	K2		
6	G2		
7	Phase		
8	DC-		
9	DC+		

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WMSC040H12TS1-A	TSPM1	WMSC040H12TS1-A6Q	Tube	16	tbd	tbd

7. Marking

Table 4. Marking codes

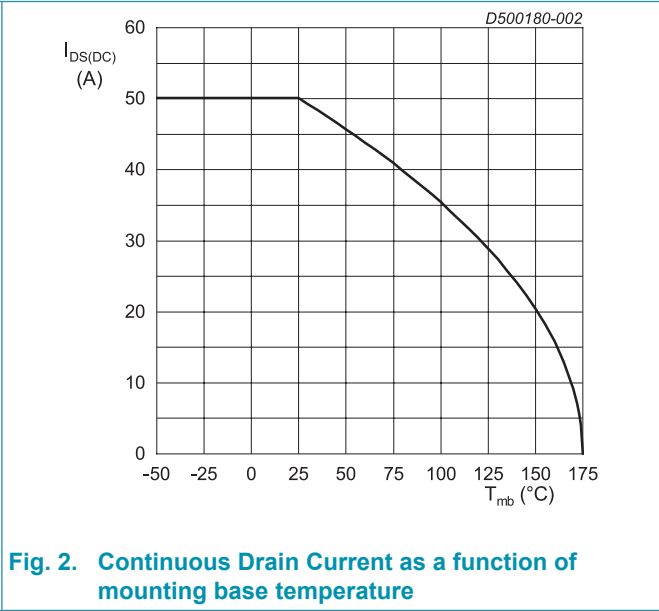
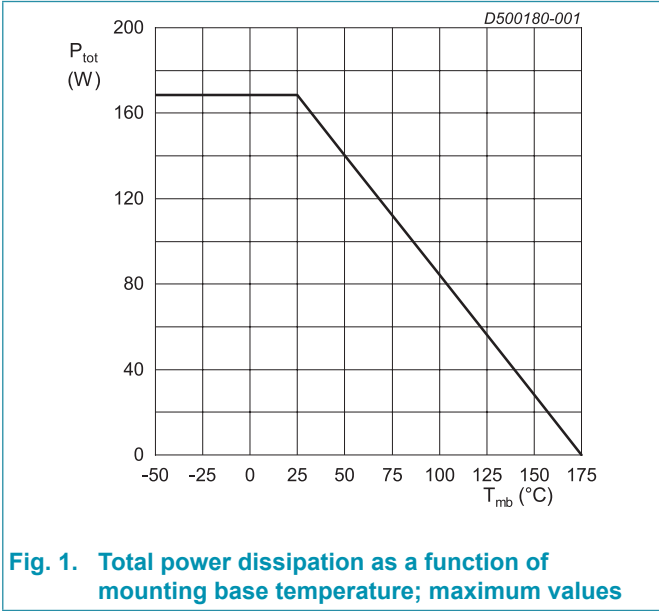
Type number	Marking codes
WMSC040H12TS1-A	WMSC 040H12TS1-A

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
T _{stg}	storage temperature			-55 to 175	°C
T _j	junction temperature			-55 to 175	°C
MOSFET					
V _{DS}	drain-source voltage	T _j = 25 °C		1200	V
V _{GS,max}	gate-source voltage	Absolute maximum values		-12 to 24	V
V _{GS,op}	gate-source voltage	Recommended operational values		-4 to 18	V
P _{tot}	total power dissipation	T _{mb} = 25 °C		169	W
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C		50	A
		V _{GS} = 18 V; T _{mb} = 100 °C		35	A
I _{DM}	peak drain current	pulse width t _p limited by T _{jmax}	Fig.17	100	A
E _{as}	single pulse drain-to-source avalanche	I _{AS} = 24 A; L = 1 mH; V _{DD} = 100 V; T _j = 25 °C		288	mJ
Body Diode					
I _{SD}	DC body diode forward current	V _{GS} = -4 V; T _j = 25 °C		29	A
I _{SD,pulse}	Pulse body diode current	V _{GS} = -4 V; pulse width t _p limited by T _{jmax}		100	A



9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base			-	0.89	-	K/W

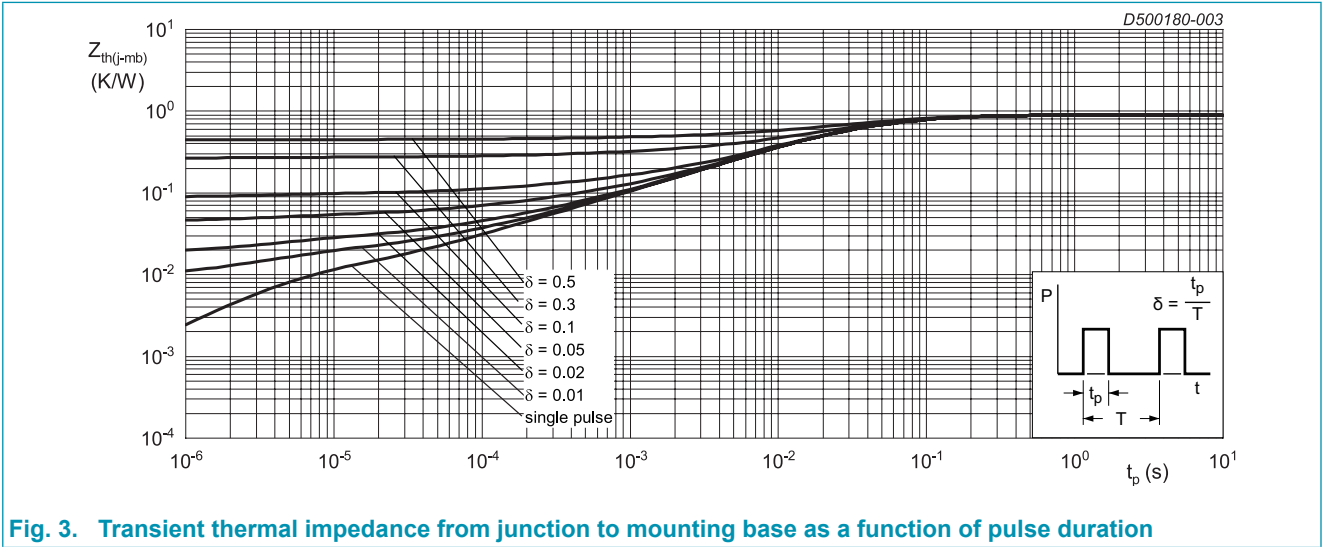


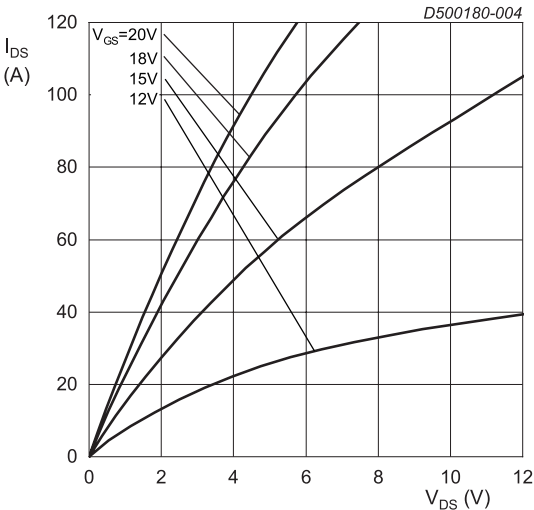
Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

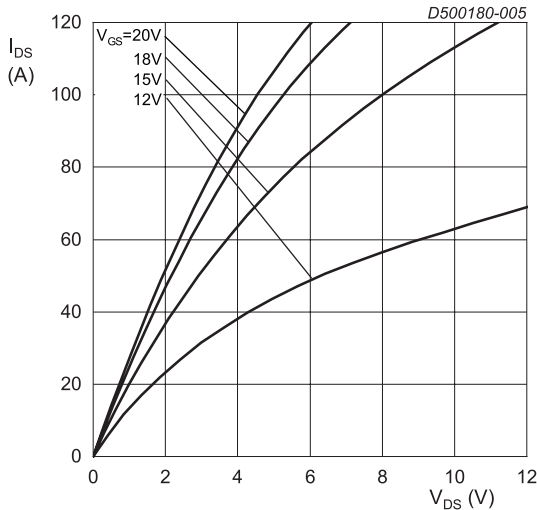
Table 7. Characteristics

MOSFET							
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 100 μA; V _{GS} = 0 V; T _J = 25 °C		1200	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 10 mA; V _{DS} = 10 V; T _J = 25 °C		1.9	2.6	3.5	V
I _{DSS}	drain leakage current	V _{DS} = 1200 V; V _{GS} = 0 V; T _J = 25 °C		-	0.2	100	μA
		V _{DS} = 1200 V; V _{GS} = 0 V; T _J = 175 °C		-	2	-	μA
I _{GSS}	gate leakage current	V _{GS} = 24 V; V _{DS} = 0 V; T _J = 25 °C		-	10	100	nA
		V _{GS} = -12 V; V _{DS} = 0 V; T _J = 25 °C		-	10	100	nA
R _{DS(on)}	drain-source on-state resistance	V _{GS} = 15 V; I _D = 33 A; T _J = 25 °C		-	40	-	mΩ
		V _{GS} = 18 V; I _D = 33 A; T _J = 25 °C		-	33	-	mΩ
		V _{GS} = 18 V; I _D = 33 A; T _J = 175 °C		-	56	-	mΩ
R _G	gate resistance	f = 1 MHz; T _J = 25 °C		-	1	-	Ω
g _{fs}	transconductance	V _{DS} = 20 V; I _D = 33 A; T _J = 25 °C		-	20	-	S
Dynamic characteristics							
Q _{G(tot)}	total gate charge	I _D = 33 A; V _{DS} = 800 V; V _{GS} = -4 V/18 V; T _J = 25 °C		-	115	-	nC
Q _{GS}	gate-source charge			-	47	-	nC
Q _{GD}	gate-drain charge			-	18	-	nC
C _{iss}	input capacitance	V _{DS} = 1000 V; V _{GS} = 0 V; f = 1 MHz; T _J = 25 °C		-	2450	-	pF
C _{oss}	output capacitance			-	108	-	pF
C _{rss}	reverse transfer capacitance			-	11	-	pF
E _{oss}	Coss stored energy			-	54	-	μJ
t _{d(on)}	turn-on delay time	V _{DS} = 800 V; V _{GS} = -4 V/18 V; R _{G(ext)} = 2.4 Ω; I _D = 33 A; L = 100 μH; T _J = 25 °C		-	10	-	ns
t _r	rise time			-	15	-	ns
t _{d(off)}	turn-off delay time			-	26	-	ns
t _f	fall time			-	9	-	ns
E _{on}	turn-on energy		Fig.20	-	351	-	μJ
E _{off}	turn-off energy		Fig.20	-	157	-	μJ
Body diode							
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
V _{SD}	source-drain voltage	V _{GS} = 0 V; I _{SD} = 16.5 A; T _J = 25 °C		-	3.5	-	V
		V _{GS} = -4 V; I _{SD} = 16.5 A; T _J = 25 °C		-	5.0	-	V
		V _{GS} = -4 V; I _{SD} = 16.5 A; T _J = 175 °C		-	4.3	-	V
t _{rr}	reverse recovery time	I _{SD} = 33 A; di/dt = 500 A/μs; V _{DS} = 400 V; T _J = 25 °C		-	52	-	ns
Q _r	recovered charge			-	174	-	nC
I _{rrm}	reverse recovery current			-	6.8	-	A

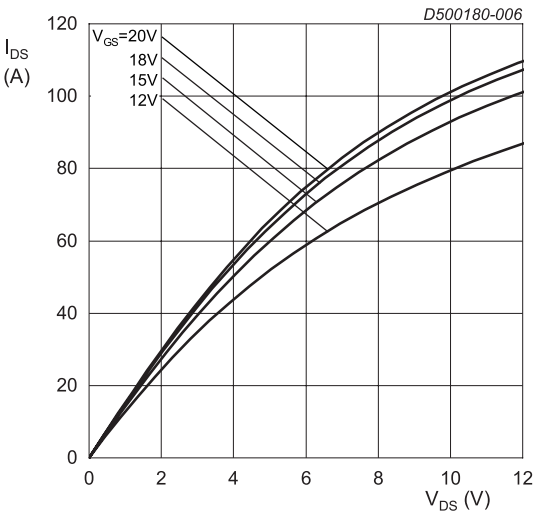
NTC thermistor							
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
R_{25}	Rated resistance	$T_{NTC} = 25\text{ }^{\circ}\text{C}$		-	10k	-	Ω
$\Delta R/R$	Resistance Tolerance	$T_{NTC} = 25\text{ }^{\circ}\text{C}$		-	$\pm 3\%$	-	
$B_{25/50}$	B-value	$R_2 = R_{25} \exp.[B_{25/50}(1/T_2 - 1/(298.15K))]$		3590			K
$B_{25/85}$	B-value	$R_2 = R_{25} \exp.[B_{25/85}(1/T_2 - 1/(298.15K))]$		3635			K
$B_{25/100}$	B-value	$R_2 = R_{25} \exp.[B_{25/100}(1/T_2 - 1/(298.15K))]$		3650			K
$\Delta B/B$	B-value Tolerance			-	$\pm 3\%$	-	
P_{Max}	Max Power Dissipation			180			mW



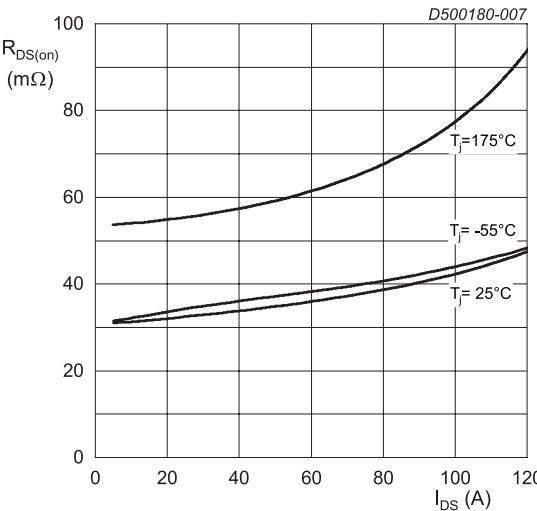
$T_J = -55\text{ }^{\circ}\text{C}; t_p < 200\text{ }\mu\text{s}$
Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



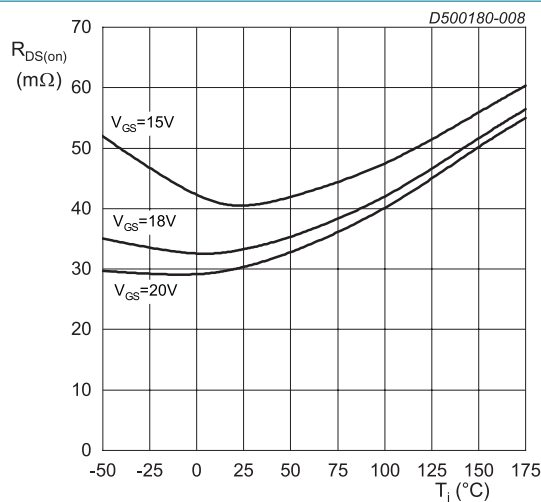
$T_J = 25\text{ }^{\circ}\text{C}; t_p < 200\text{ }\mu\text{s}$
Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



$T_J = 175\text{ }^{\circ}\text{C}; t_p < 200\text{ }\mu\text{s}$
Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

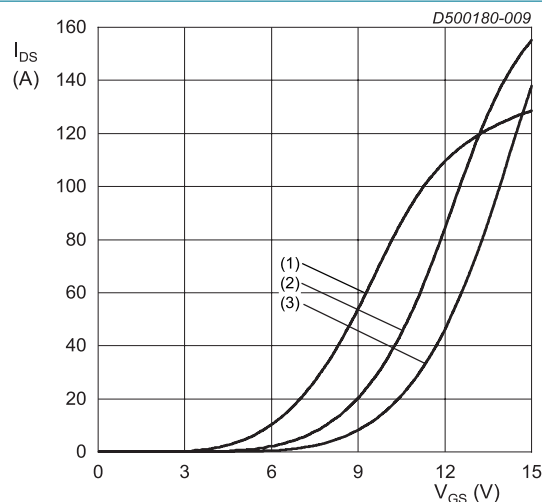


$V_{GS} = 18\text{ V}; t_p < 200\text{ }\mu\text{s}$
Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



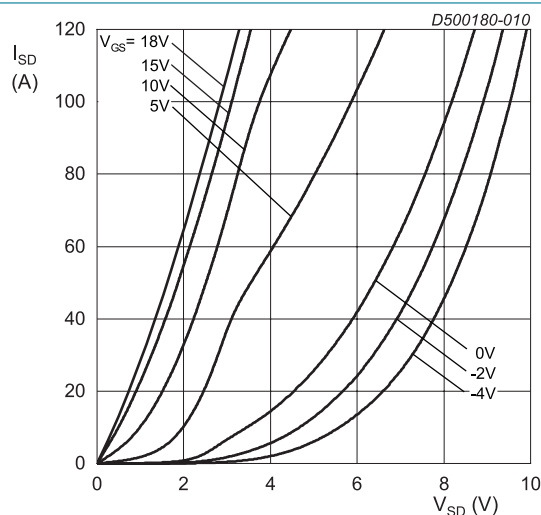
$I_{DS} = 33\text{ A}$; $t_p < 200\text{ }\mu\text{s}$

Fig. 8. Drain-source on-state resistance as a function of junction temperature



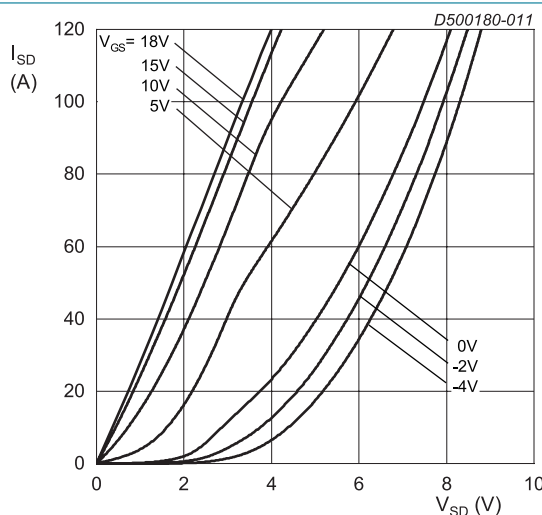
$V_{DS} = 20\text{ V}$; $t_p < 200\text{ }\mu\text{s}$

Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values



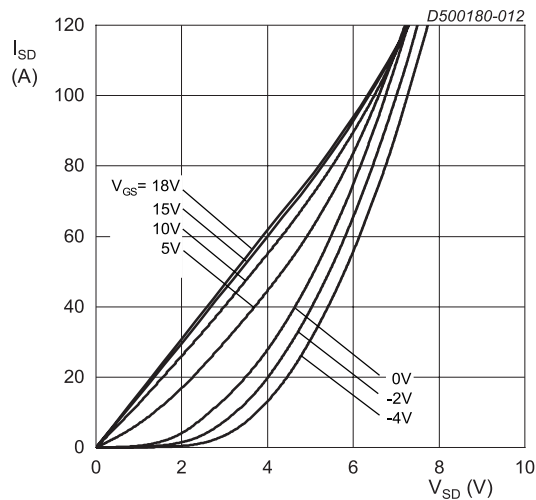
$T_j = -55\text{ }^\circ\text{C}$; $t_p < 200\text{ }\mu\text{s}$

Fig. 10. Body diode forward characteristics; typical values

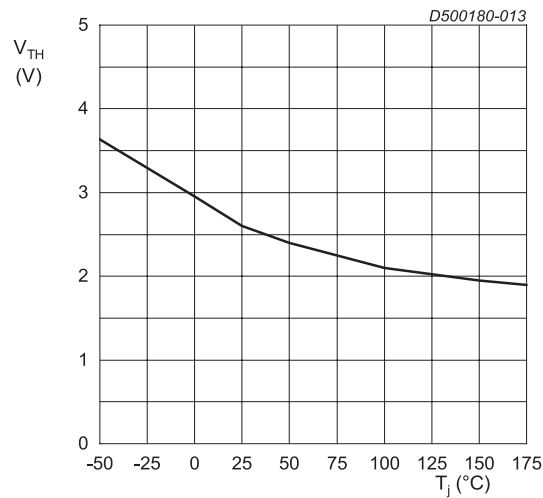


$T_j = 25\text{ }^\circ\text{C}$; $t_p < 200\text{ }\mu\text{s}$

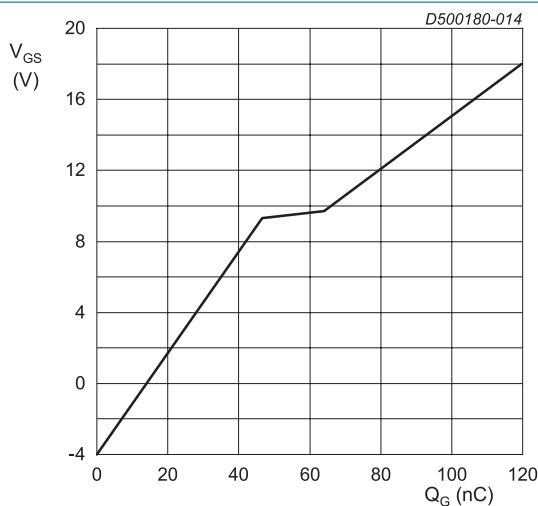
Fig. 11. Body diode forward characteristics; typical values



$T_j = 175\text{ }^{\circ}\text{C}$; $t_p < 200\text{ }\mu\text{s}$
Fig. 12. Body diode forward characteristics; typical values



$V_{DS} = 10\text{ V}$; $I_{DS} = 10\text{ mA}$
Fig. 13. Threshold voltage as a function of junction temperature



$I_{DS} = 33\text{ A}$; $I_{GS} = 0.1\text{ mA}$; $V_{DS} = 800\text{ V}$; $T_j = 25\text{ }^{\circ}\text{C}$
Fig. 14. Gate-source voltage as a function of gate charge; typical values

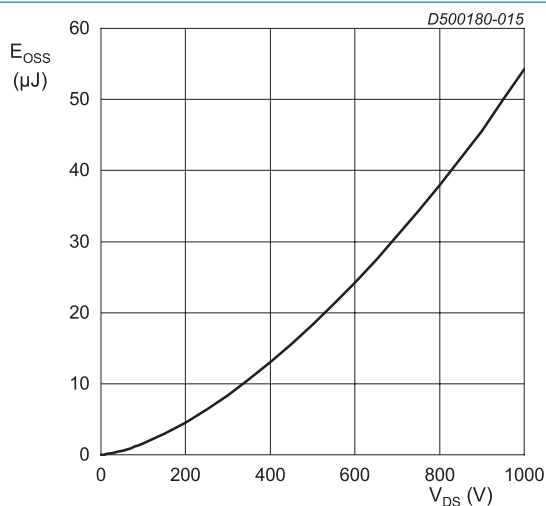
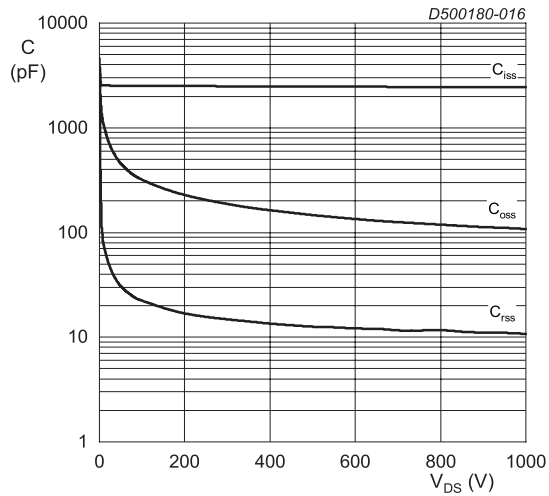
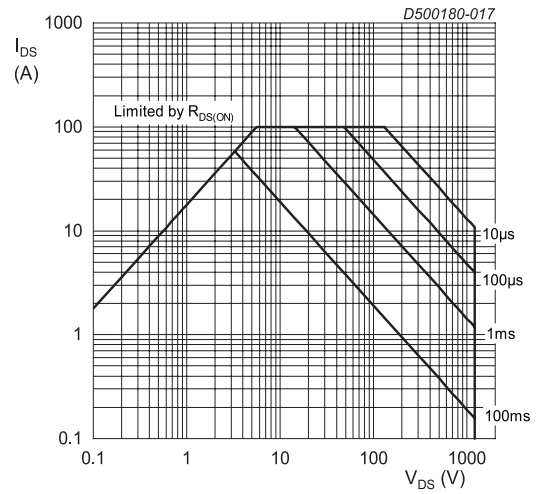


Fig. 15. Output capacitor stored energy as a function of drain-source voltage



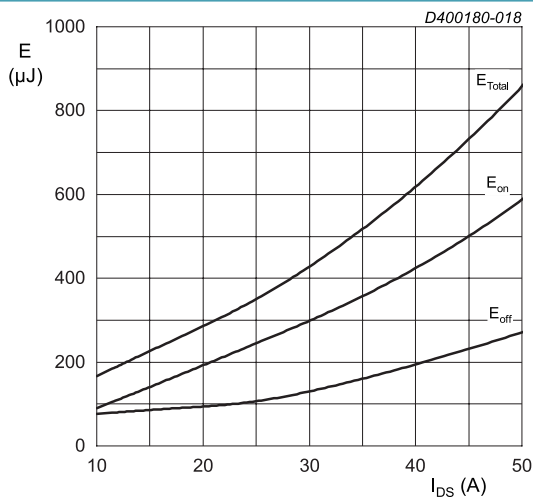
$V_{DS} = 0 - 1000 \text{ V}$
 $T_j = 25^\circ\text{C}$; $V_{AC} = 25 \text{ mV}$; $f = 1 \text{ MHz}$

Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



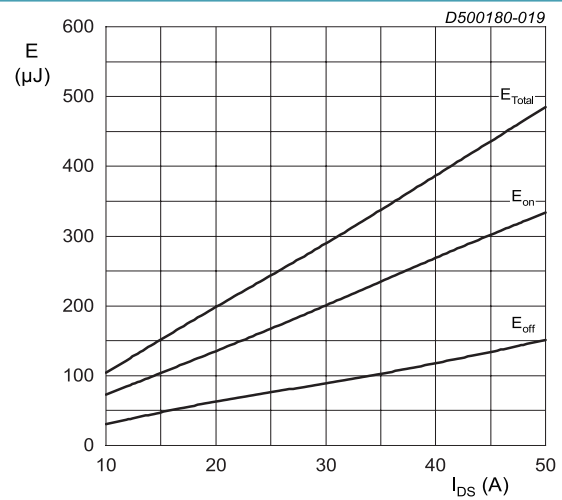
$T_j = 25^\circ\text{C}$; $D = 0$
 Parameter: t_p

Fig. 17. Forward bias safe operating area



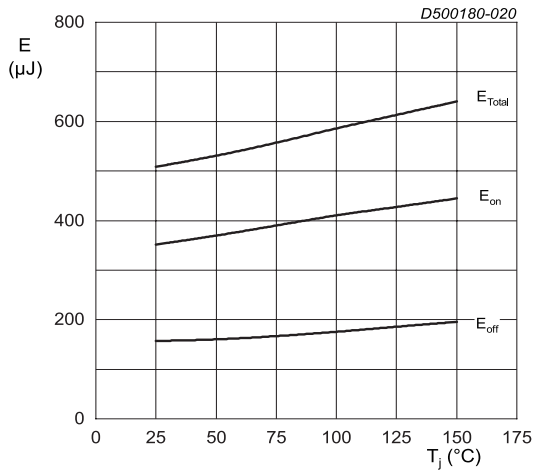
$T_j = 25^\circ\text{C}$; $V_{DD} = 800 \text{ V}$; $R_{G(ext)} = 2.4 \Omega$;
 $V_{GS} = -4 \text{ V}/18 \text{ V}$; $L = 100 \mu\text{H}$

Fig. 18. Clamped Inductive Switching Energy as a function of drain current



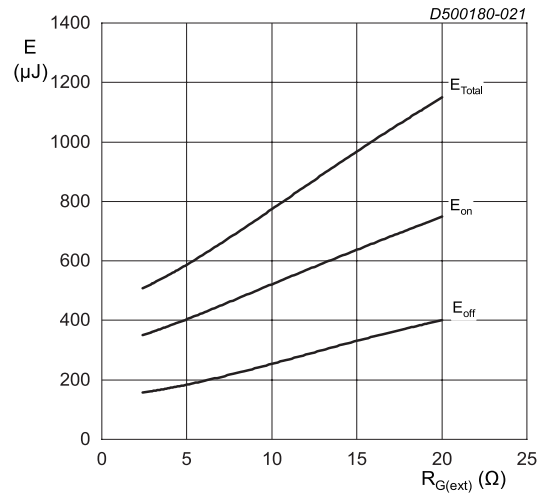
$T_j = 25^\circ\text{C}$; $V_{DD} = 600 \text{ V}$; $R_{G(ext)} = 2.4 \Omega$;
 $V_{GS} = -4 \text{ V}/18 \text{ V}$; $L = 100 \mu\text{H}$

Fig. 19. Clamped Inductive Switching Energy as a function of drain current



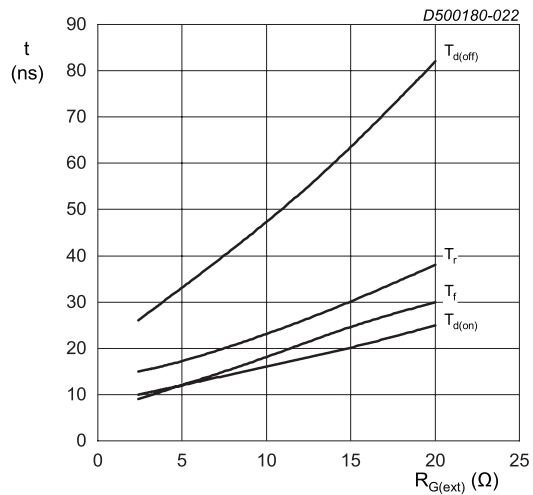
$I_{DS} = 33\text{ A}$; $V_{DD} = 800\text{ V}$; $R_{G(ext)} = 2.4\ \Omega$;
 $V_{GS} = -4\text{ V}/18\text{ V}$; $L = 100\ \mu\text{H}$

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



$T_j = 25\text{ °C}$; $V_{DD} = 800\text{ V}$; $I_{DS} = 33\text{ A}$; $V_{GS} = -4\text{ V}/18\text{ V}$
 $L = 100\ \mu\text{H}$

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



$T_j = 25\text{ °C}$; $V_{DD} = 800\text{ V}$; $I_{DS} = 33\text{ A}$; $V_{GS} = -4\text{ V}/18\text{ V}$
 $L = 100\ \mu\text{H}$

Fig. 22. Switching time as a function of external gate resistance

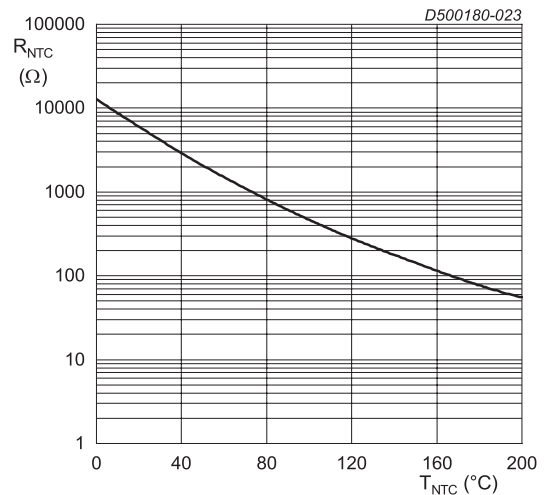
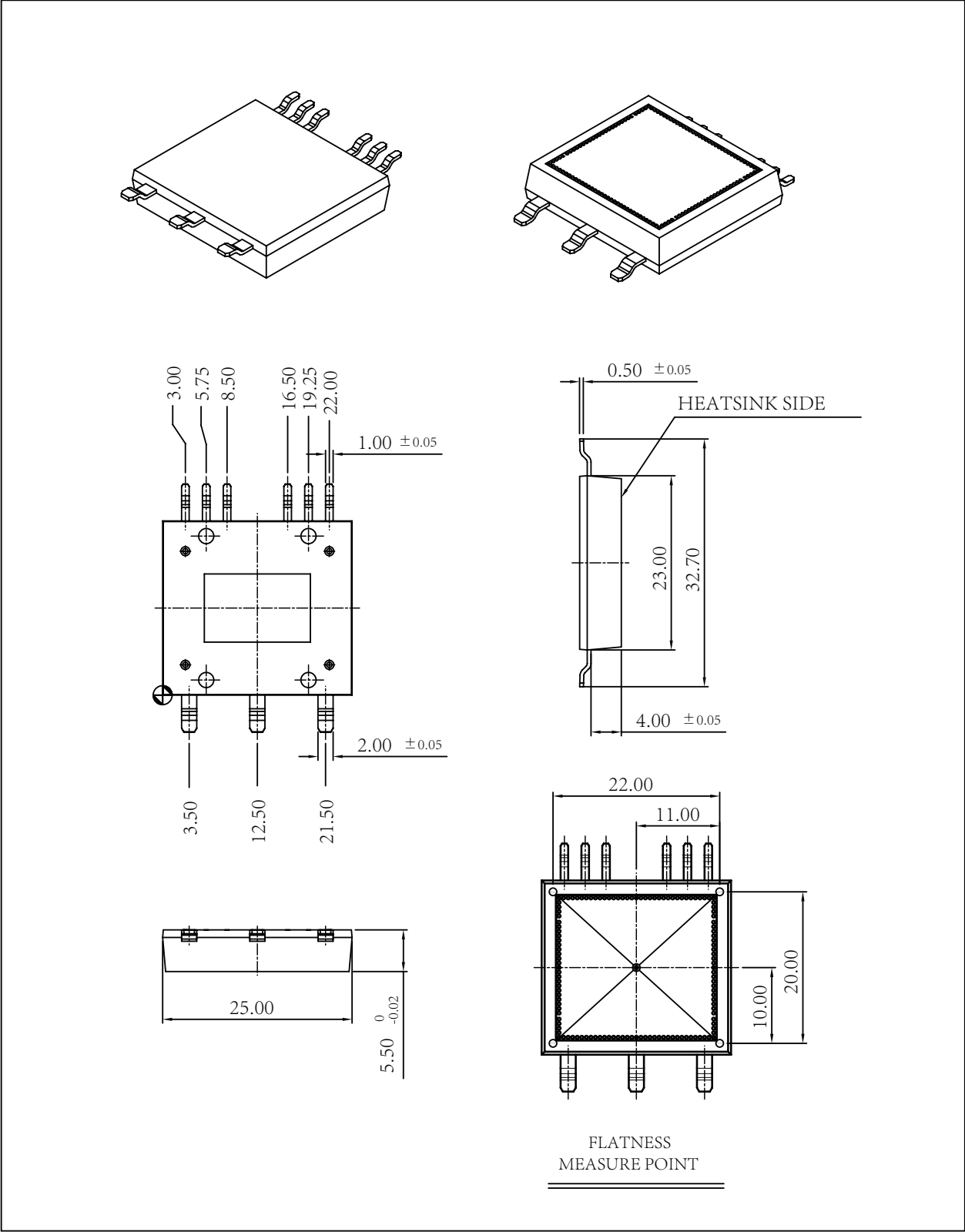


Fig. 23. NTC thermistor resistance as a function of NTC temperature

11. Package outline

TSPM1



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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